

Search Notes

Application/Control No.

09/840,861

Examiner

Young J. Kim

Applicant(s)/Patent under
Reexamination

DUPRET ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	7/27/2005	YJK
See enclosed search strategy	7/27/2005	YJK